intersil

Data Sheet | August 31, 2015 | FN4022.15

100V/2A Peak, Low Cost, High Frequency Half Bridge Driver

The HIP2100 is a high frequency, 100V Half Bridge N-Channel power MOSFET driver IC. The low-side and high-side gate drivers are independently controlled and matched to 8ns. This gives the user maximum flexibility in dead-time selection and driver protocol. Undervoltage protection on both the low-side and high-side supplies force the outputs low. An on-chip diode eliminates the discrete diode required with other driver ICs. A new level-shifter topology yields the low-power benefits of pulsed operation with the safety of DC operation. Unlike some competitors, the high-side output returns to its correct state after a momentary undervoltage of the high-side supply.

Applications

- Telecom Half Bridge Power Supplies
- Avionics DC/DC Converters
- Two-Switch Forward Converters
- Active Clamp Forward Converters

Features

- Drives N-Channel MOSFET Half Bridge
- SOIC, EPSOIC, QFN and DFN Package Options
- SOIC, EPSOIC and DFN Packages Compliant with 100V Conductor Spacing Guidelines of IPC-2221
- Pb-Free Product Available (RoHS Compliant)
- Bootstrap Supply Max Voltage to 114VDC
- On-Chip 1Ω Bootstrap Diode
- Fast Propagation Times for Multi-MHz Circuits
- Drives 1000pF Load with Rise and Fall Times Typ. 10ns
- CMOS Input Thresholds for Improved Noise Immunity
- Independent Inputs for Non-Half Bridge Topologies
- No Start-Up Problems
- Outputs Unaffected by Supply Glitches, HS Ringing Below Ground, or HS Slewing at High dv/dt
- Low Power Consumption
- Wide Supply Range
- Supply Undervoltage Protection
- 3Ω Driver Output Resistance
- QFN/DFN Package:
  - Compliant to JEDEC PUB95 MO-220 QFN - Quad Flat No Leads - Package Outline
  - Near Chip Scale Package Footprint, which Improves PCB Efficiency and has a Thinner Profile
  -

Ordering Information

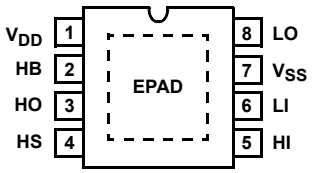
PART NUMBER (Note 1)	PART MARKING	TEMP. RANGE (°C)	PACKAGE	PKG. DWG. #
HIP2100IB **(No longer available, recommended replacements: HIP2100IBZ, HIP2100IBZT)**	2100 IB	-40 to +125	8 Ld SOIC	M8.15
HIP2100IBZ (Note 2)	2100 IBZ	-40 to +125	8 Ld SOIC (Pb-free)	M8.15
HIP2100EIBZ (Note 2)	2100 EIBZ	-40 to +125	8 Ld EPSOIC (Pb-free)	M8.15C
HIP2100IRZ (Note 2)	HIP 2100IRZ	-40 to +125	16 Ld 5x5 QFN (Pb-free)	L16.5x5
HIP2100IR4Z (Note 2) **(No longer available, recommended replacements: HIP2100IRZ, HIP2100IRZT)**	21 00IR4Z	-40 to +125	12 Ld 4x4 DFN (Pb-free)	L12.4x4A

NOTES:

1. Add “T” suffix for tape and reel. Please refer to TB347 for details on reel specifications.
2. These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

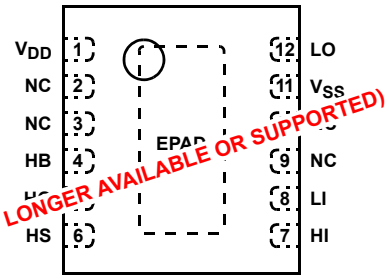
Pinouts

HIP2100
(8 LD SOIC, EPSOIC)
TOP VIEW



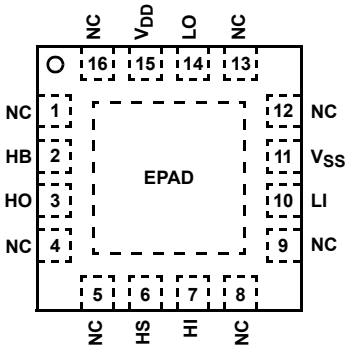
NOTE: EPAD = Exposed PAD.

HIP2100IR4
(12 LD DFN)
TOP VIEW

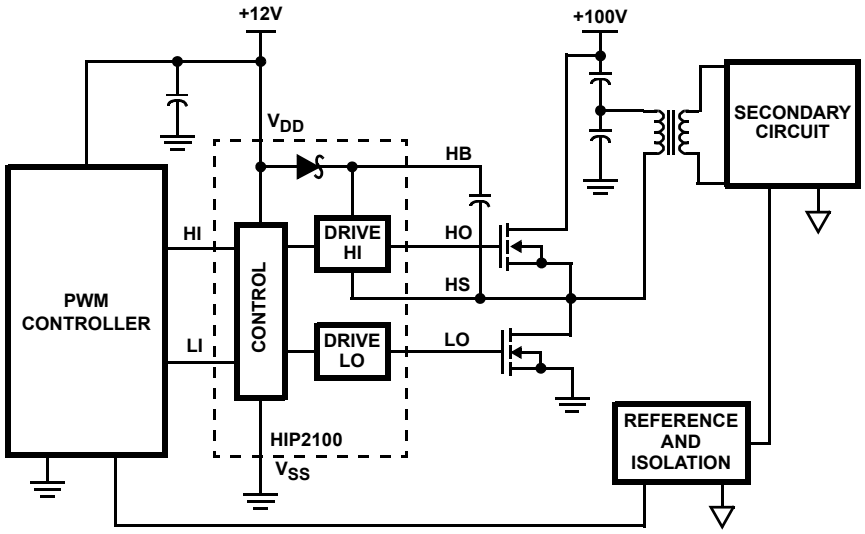


NO LONGER AVAILABLE OR SUPPORTED)

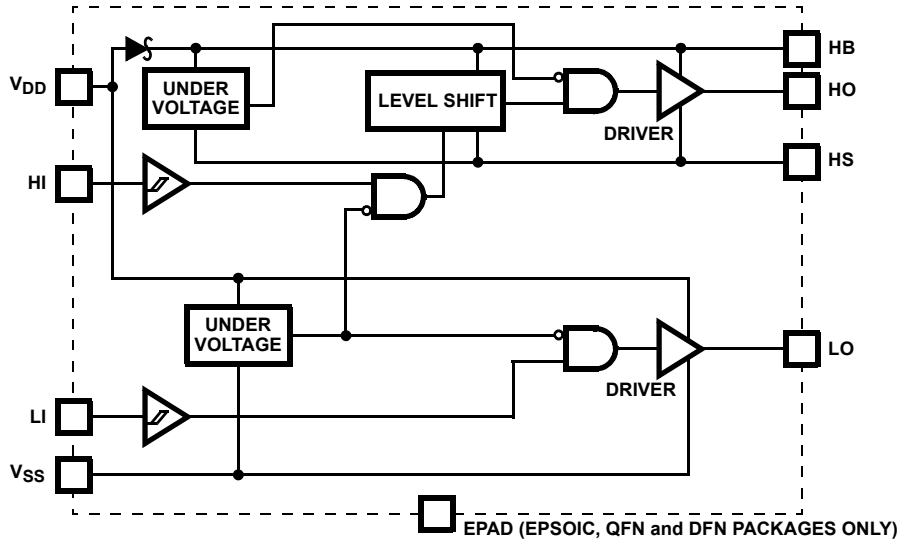
HIP2100
(16 LD QFN)
TOP VIEW



Application Block Diagram



Functional Block Diagram



*EPAD = Exposed Pad. The EPAD is electrically isolated from all other pins. For best thermal performance connect the EPAD to the PCB power ground plane.

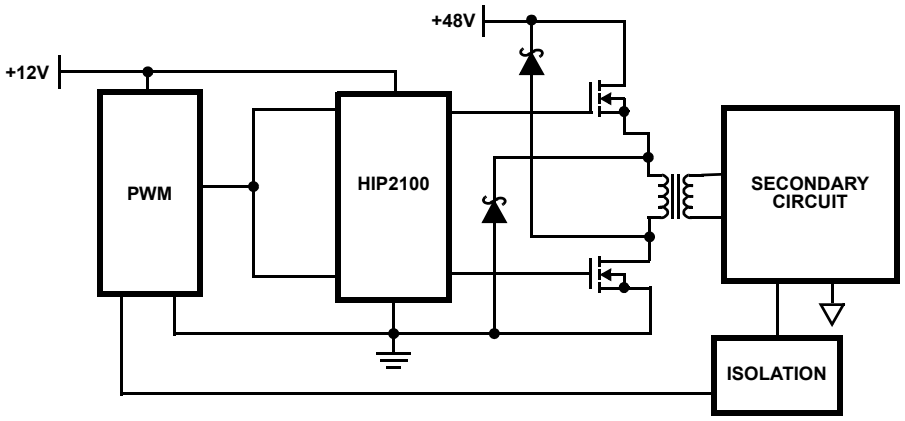


FIGURE 1. TWO-SWITCH FORWARD CONVERTER

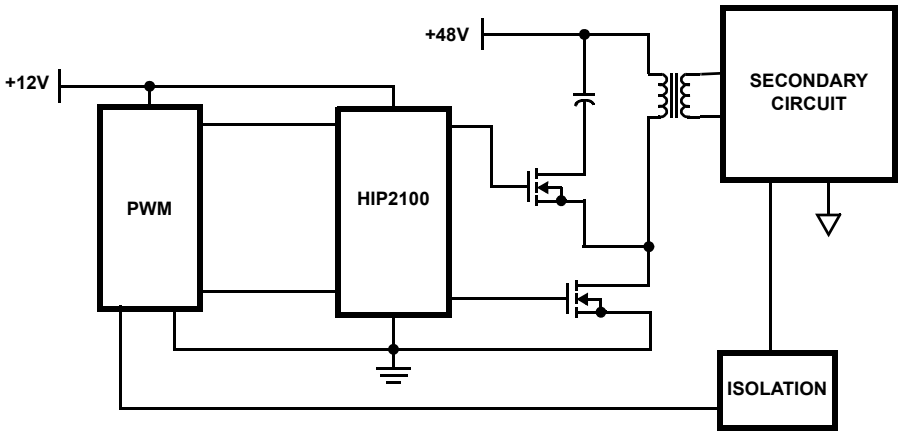


FIGURE 2. FORWARD CONVERTER WITH AN ACTIVE CLAMP

Absolute Maximum Ratings

Supply Voltage, V_{DD}, V_{HB}-V_{HS} (Notes 3, 4) . . . . . -0.3V to 18V
LI and HI Voltages (Note 4) . . . . . -0.3V to V_{DD} +0.3V
Voltage on LO (Note 4) . . . . . -0.3V to V_{DD} +0.3V
Voltage on HO (Note 4) . . . . . V_{HS} -0.3V to V_{HB} +0.3V
Voltage on HS (Continuous) (Note 4) . . . . . -1V to 110V
Voltage on HB (Note 4) . . . . . +118V
Average Current in V_{DD} to HB diode 100mA
ESD Classification . . . . . Class 1 (1kV)

Maximum Recommended Operating Conditions

Supply Voltage, V_{DD} . . . . . +9V to 14.0VDC
Voltage on HS . . . . . -1V to 100V
Voltage on HS . . . . . (Repetitive Transient) -5V to 105V
Voltage on HB . . . V_{HS} +8V to V_{HS} +14.0V and V_{DD} -1V to V_{DD} +100V
HS Slew Rate. . . . . <50V/ns

Thermal Information

Thermal Resistance (Typical)	θ_{JA} (°C/W)	θ_{JC} (°C/W)
SOIC (Note 5)	95	50
EPSOIC (Note 6)	40	3.0
QFN (Note 6)	37	6.5
DFN (Note 6)	40	3.0

Max Power Dissipation at +25°C in Free Air (SOIC, Note 5) 1.3W
Max Power Dissipation at +25°C in Free Air (EPSOIC, Note 6) . . 3.1W
Max Power Dissipation at +25°C in Free Air (QFN, Note 6) 3.3W
Storage Temperature Range . . . . . .-65°C to +150°C
Junction Temperature Range. . . . . .-55°C to +150°C
Pb-Free Reflow Profile. . . . . .see link below
http://www.intersil.com/pbfree/Pb-FreeReflow.asp

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

NOTES:

3. The HIP2100 is capable of derated operation at supply voltages exceeding 14V. Figure 16 shows the high-side voltage derating curve for this mode of operation.
4. All voltages referenced to V_{SS} unless otherwise specified.
5. θ_{JA} is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.
6. θ_{JA} is measured in free air with the component mounted on a high effective thermal conductivity test board with “direct attach” features. θ_{JC}, the “case temp” is measured at the center of the exposed metal pad on the package underside. See Tech Brief TB379.

Electrical Specifications

V_{DD} = V_{HB} = 12V, V_{SS} = V_{HS} = 0V, No Load on LO or HO, Unless Otherwise Specified.

PARAMETERS	SYMBOL	TEST CONDITIONS	T_J = +25°C			T_J = -40°C TO +125°C		UNITS
			MIN	TYP	MAX	MIN (Note 7)	MAX (Note 7)	
SUPPLY CURRENTS								
V_{DD} Quiescent Current	I_{DD}	LI = HI = 0V	-	0.1	0.15	-	0.2	mA
V_{DD} Operating Current	I_{DDO}	f = 500kHz	-	1.5	2.5	-	3	mA
Total HB Quiescent Current	I_{HB}	LI = HI = 0V	-	0.1	0.15	-	0.2	mA
Total HB Operating Current	I_{HBO}	f = 500kHz	-	1.5	2.5	-	3	mA
HB to V_{SS} Current, Quiescent	I_{HBS}	V_{HS} = V_{HB} = 114V	-	0.05	1	-	10	µA
HB to V_{SS} Current, Operating	I_{HBSO}	f = 500kHz	-	0.7	-	-	-	mA
INPUT PINS								
Low Level Input Voltage Threshold	V_{IL}		4	5.4	-	3	-	V
High Level Input Voltage Threshold	V_{IH}		-	5.8	7	-	8	V
Input Voltage Hysteresis	V_{IHYS}		-	0.4	-	-	-	V
Input Pulldown Resistance	R_I		-	200	-	100	500	kΩ
UNDERVOLTAGE PROTECTION								
V_{DD} Rising Threshold	V_{DDR}		7	7.3	7.8	6.5	8	V
V_{DD} Threshold Hysteresis	V_{DDH}		-	0.5	-	-	-	V
HB Rising Threshold	V_{HBR}		6.5	6.9	7.5	6	8	V
HB Threshold Hysteresis	V_{HBH}		-	0.4	-	-	-	V

Electrical Specifications $V_{DD} = V_{HB} = 12V$, $V_{SS} = V_{HS} = 0V$, No Load on LO or HO, Unless Otherwise Specified. **(Continued)**

PARAMETERS	SYMBOL	TEST CONDITIONS	T_J = +25°C			T_J = -40°C TO +125°C		UNITS
			MIN	TYP	MAX	MIN (Note 7)	MAX (Note 7)	
BOOT STRAP DIODE								
Low-Current Forward Voltage	V_{DL}	I_{VDD-HB} = 100µA	-	0.45	0.55	-	0.7	V
High-Current Forward Voltage	V_{DH}	I_{VDD-HB} = 100mA	-	0.7	0.8	-	1	V
Dynamic Resistance	R_D	I_{VDD-HB} = 100mA	-	0.8	1	-	1.5	Ω
LO GATE DRIVER								
Low Level Output Voltage	V_{OLL}	I_{LO} = 100mA	-	0.25	0.3	-	0.4	V
High Level Output Voltage	V_{OHL}	I_{LO} = -100mA, $V_{OHL} = V_{DD}-V_{LO}$	-	0.25	0.3	-	0.4	V
Peak Pullup Current	I_{OHL}	V_{LO} = 0V	-	2	-	-	-	A
Peak Pulldown Current	I_{OLL}	V_{LO} = 12V	-	2	-	-	-	A
HO GATE DRIVER								
Low Level Output Voltage	V_{OLH}	I_{HO} = 100mA	-	0.25	0.3	-	0.4	V
High Level Output Voltage	V_{OHH}	I_{HO} = -100mA, $V_{OHH} = V_{HB}-V_{HO}$	-	0.25	0.3	-	0.4	V
Peak Pullup Current	I_{OHH}	V_{HO} = 0V	-	2	-	-	-	A
Peak Pulldown Current	I_{OLH}	V_{HO} = 12V	-	2	-	-	-	A

Switching Specifications $V_{DD} = V_{HB} = 12V$, $V_{SS} = V_{HS} = 0V$, No Load on LO or HO, Unless Otherwise Specified.

PARAMETERS	SYMBOL	TEST CONDITIONS	T_J = +25°C			T_J = -40°C TO +125°C		UNITS
			MIN	TYP	MAX	MIN (Note 7)	MAX (Note 7)	
Lower Turn-Off Propagation Delay (LI Falling to LO Falling)	t_{LPHL}		-	20	35	-	45	ns
Upper Turn-Off Propagation Delay (HI Falling to HO Falling)	t_{HPHL}		-	20	35	-	45	ns
Lower Turn-On Propagation Delay (LI Rising to LO Rising)	t_{LPLH}		-	20	35	-	45	ns
Upper Turn-On Propagation Delay (HI Rising to HO Rising)	t_{HPLH}		-	20	35	-	45	ns
Delay Matching: Lower Turn-On and Upper Turn-Off	t_{MON}		-	2	8	-	10	ns
Delay Matching: Lower Turn-Off and Upper Turn-On	t_{MOFF}		-	2	8	-	10	ns
Either Output Rise/Fall Time	t_{RC}, t_{FC}	C_L = 1000pF	-	10	-	-	-	ns
Either Output Rise/Fall Time (3V to 9V)	t_R, t_F	C_L = 0.1µF	-	0.5	0.6	-	0.8	µs
Either Output Rise Time Driving DMOS	t_{RD}	C_L = IRFR120	-	20	-	-	-	ns
Either Output Fall Time Driving DMOS	t_{FD}	C_L = IRFR120	-	10	-	-	-	ns
Minimum Input Pulse Width that Changes the Output	t_{PW}		-	-	-	-	50	ns
Bootstrap Diode Turn-On or Turn-Off Time	t_{BS}		-	10	-	-	-	ns

NOTE:

7. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.

Pin Descriptions

SYMBOL	DESCRIPTION
V_{DD}	Positive Supply to lower gate drivers. De-couple this pin to V_{SS}. Bootstrap diode connected to HB.
HB	High-Side Bootstrap supply. External bootstrap capacitor is required. Connect positive side of bootstrap capacitor to this pin. Bootstrap diode is on-chip.
HO	High-Side Output. Connect to gate of High-Side power MOSFET.
HS	High-Side Source connection. Connect to source of High-Side power MOSFET. Connect negative side of bootstrap capacitor to this pin.
HI	High-Side input.
LI	Low-Side input.
V_{SS}	Chip negative supply, generally will be ground.
LO	Low-Side Output. Connect to gate of Low-Side power MOSFET.
EPAD	Exposed Pad. Connect to ground or float. The EPAD is electrically isolated from all other pins.

Timing Diagrams

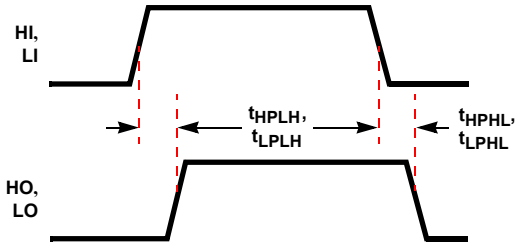


FIGURE 3.

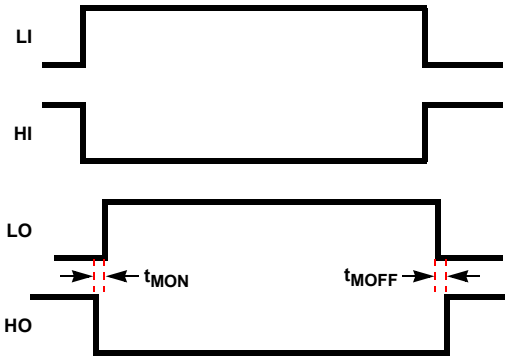


FIGURE 4.

Typical Performance Curves

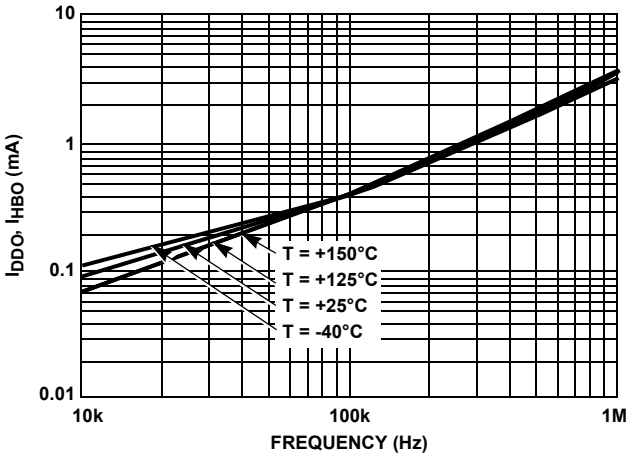


FIGURE 5. OPERATING CURRENT vs FREQUENCY

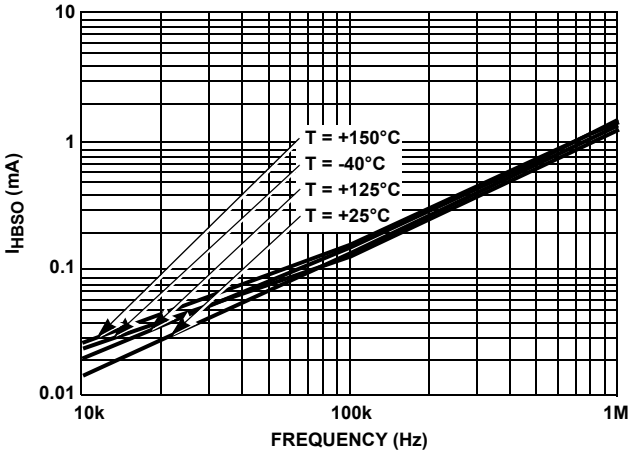


FIGURE 6. HB TO V_{SS} OPERATING CURRENT vs FREQUENCY

Typical Performance Curves (Continued)

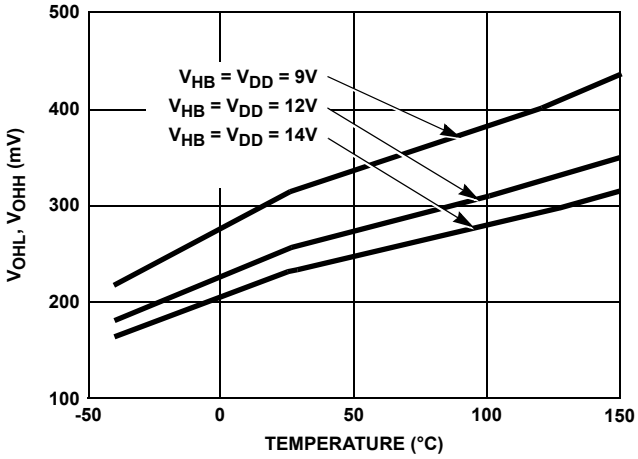


FIGURE 7. HIGH LEVEL OUTPUT VOLTAGE vs TEMPERATURE

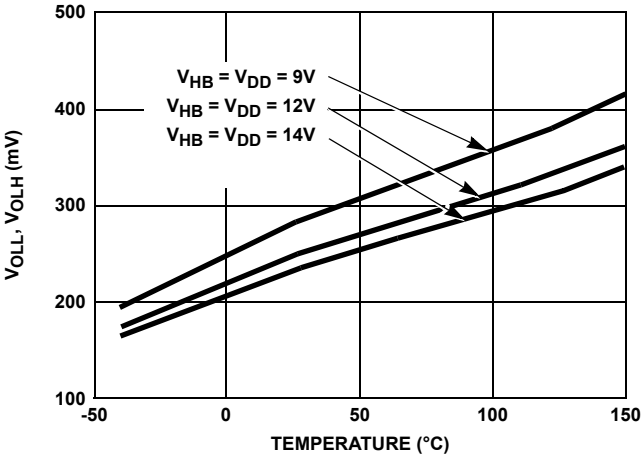


FIGURE 8. LOW LEVEL OUTPUT VOLTAGE vs TEMPERATURE

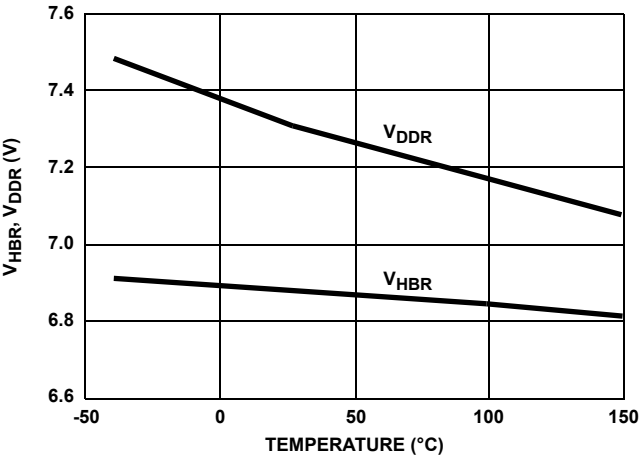


FIGURE 9. UNDERVOLTAGE LOCKOUT THRESHOLD vs TEMPERATURE

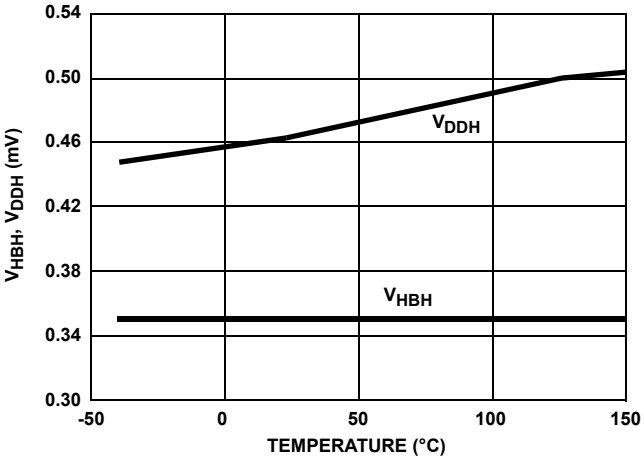


FIGURE 10. UNDERVOLTAGE LOCKOUT HYSTERESIS vs TEMPERATURE

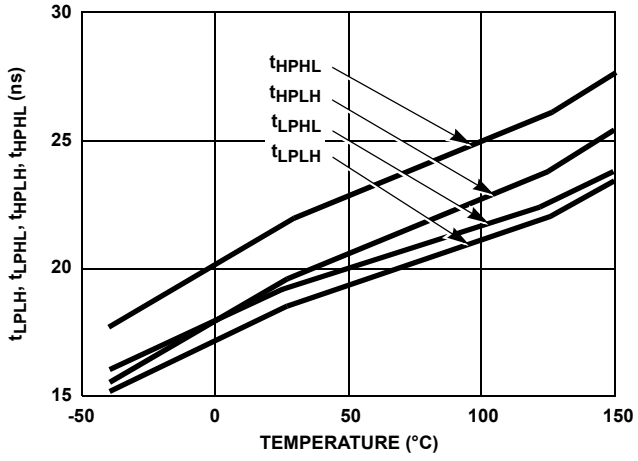


FIGURE 11. PROPAGATION DELAYS vs TEMPERATURE

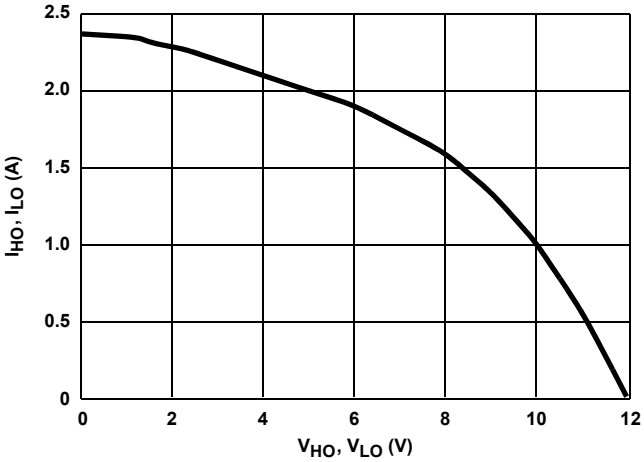


FIGURE 12. PEAK PULLUP CURRENT vs OUTPUT VOLTAGE

Typical Performance Curves (Continued)

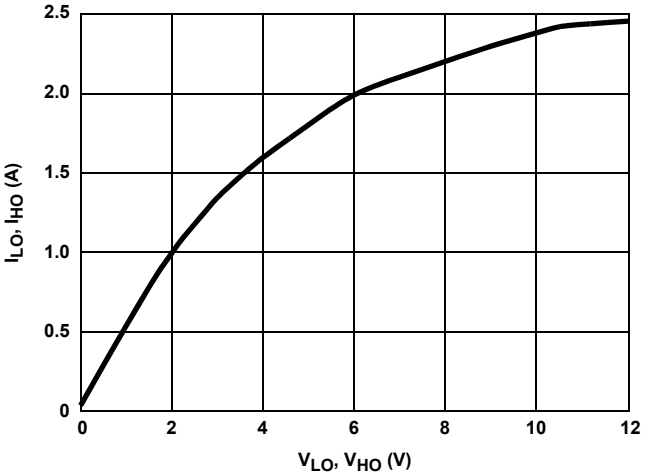


FIGURE 13. PEAK PULLDOWN CURRENT vs OUTPUT VOLTAGE

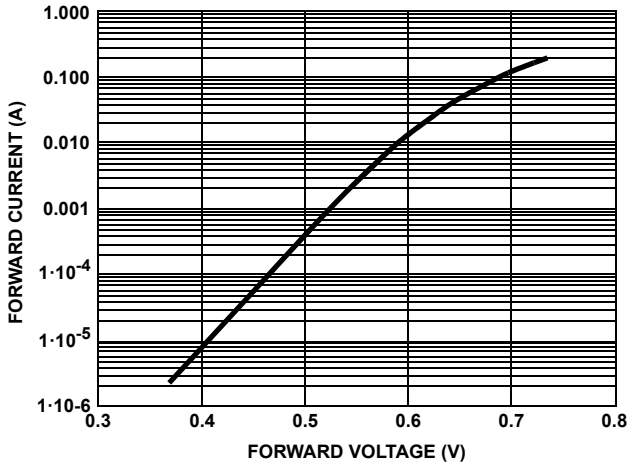


FIGURE 14. BOOTSTRAP DIODE I-V CHARACTERISTICS

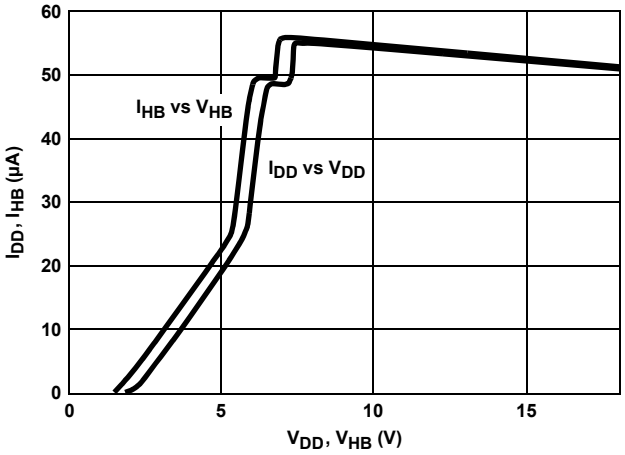


FIGURE 15. QUIESCENT CURRENT vs VOLTAGE

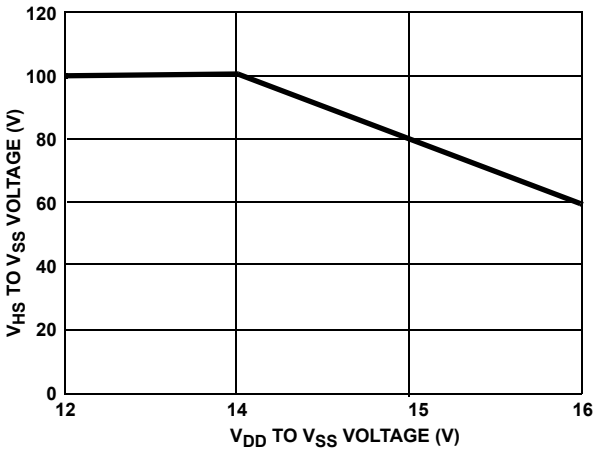


FIGURE 16. V_{HS} VOLTAGE vs V_{DD} VOLTAGE

Revision History

The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to the web to make sure that you have the latest revision.

DATE	REVISION	CHANGE
August 31, 2015	FN4022.15	Updated Ordering Information Table on page 1. Added Revision History and About Intersil sections. Updated POD M8.15 from rev 1 to rev 4. Changes since rev 1: Updated to new format by removing table, moving dimensions onto drawing and adding land pattern Typical Recommended Land Pattern, changed the following: 2.41(0.095) to 2.20(0.087) 0.76 (0.030) to 0.60(0.023) 0.200 to 5.20(0.205) Changed Note 1 "1982" to "1994"

About Intersil

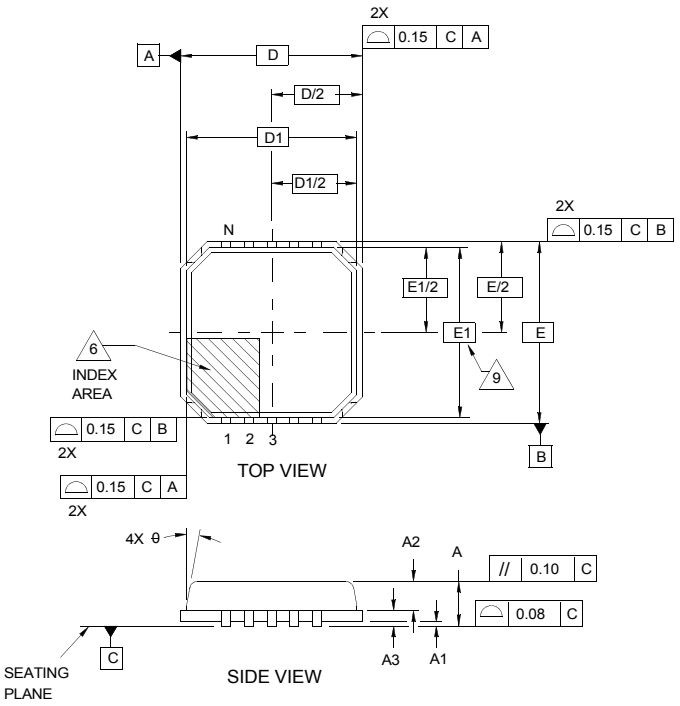
Intersil Corporation is a leading provider of innovative power management and precision analog solutions. The company's products address some of the largest markets within the industrial and infrastructure, mobile computing and high-end consumer markets.

For the most updated datasheet, application notes, related documentation and related parts, please see the respective product information page found at www.intersil.com.

You may report errors or suggestions for improving this datasheet by visiting www.intersil.com/ask.

Reliability reports are also available from our website at www.intersil.com/support

Dual Flat No-Lead Plastic Package (DFN)
Micro Lead Frame Plastic Package (MLFP)



L12.4x4A

12 LEAD DUAL FLAT NO-LEAD PLASTIC PACKAGE

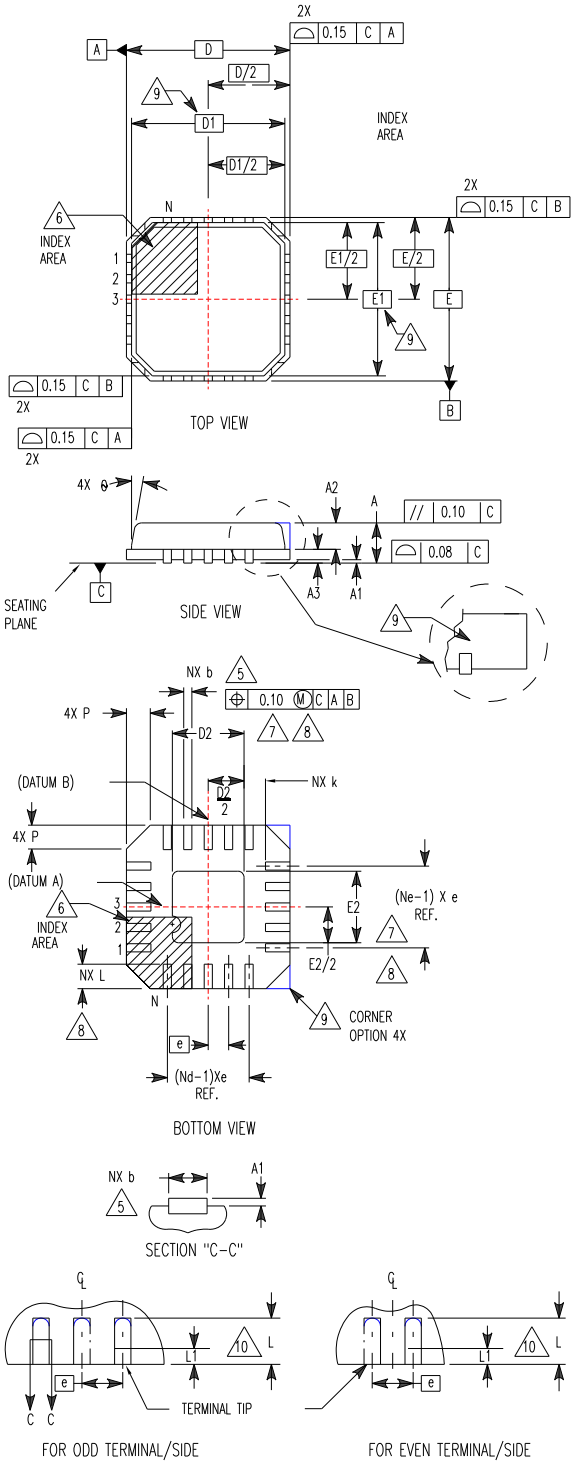
SYMBOL	MILLIMETERS			NOTES
	MIN	NOMINAL	MAX	
A	-	0.85	0.90	-
A1	0.00	0.01	0.05	-
A2	-	0.65	0.70	-
A3		0.20 REF		-
b	0.18	0.23	0.30	5, 8
D		4.00 BSC		-
D1		3.75 BSC		-
D2	2.65	2.80	2.95	7, 8
E		4.00 BSC		-
E1		3.75 BSC		-
E2	1.43	1.58	1.73	7, 8
e		0.50 BSC		-
k	0.635	-	-	-
L	0.30	0.40	0.50	8
N		12		2
Nd		6		3
P	0.24	0.42	0.60	-
θ	-	-	12	-

Rev. 0 8/03

NOTES:

1. Dimensioning and tolerancing conform to ASME Y14.5M-1994.
2. N is the number of terminals.
3. Nd refer to the number of terminals on D.
4. All dimensions are in millimeters. Angles are in degrees.
5. Dimension b applies to the metallized terminal and is measured between 0.15mm and 0.30mm from the terminal tip.
6. The configuration of the pin #1 identifier is optional, but must be located within the zone indicated. The pin #1 identifier may be either a mold or mark feature.
7. Dimensions D2 and E2 are for the exposed pads which provide improved electrical and thermal performance.
8. Nominal dimensions are provided to assist with PCB Land Pattern Design efforts, see Intersil Technical Brief TB389.
9. COMPLIANT TO JEDEC MO-229-VGGD-2 ISSUE C except for the L dimension.

Quad Flat No-Lead Plastic Package (QFN)
Micro Lead Frame Plastic Package (MLFP)



L16.5x5

16 LEAD QUAD FLAT NO-LEAD PLASTIC PACKAGE (COMPLIANT TO JEDEC MO-220VHHB ISSUE C)

SYMBOL	MILLIMETERS			NOTES
	MIN	NOMINAL	MAX	
A	0.80	0.90	1.00	-
A1	-	-	0.05	-
A2	-	-	1.00	9
A3		0.20 REF		9
b	0.28	0.33	0.40	5, 8
D		5.00 BSC		-
D1		4.75 BSC		9
D2	2.55	2.70	2.85	7, 8
E		5.00 BSC		-
E1		4.75 BSC		9
E2	2.55	2.70	2.85	7, 8
e		0.80 BSC		-
k	0.25	-	-	-
L	0.35	0.60	0.75	8
L1	-	-	0.15	10
N		16		2
Nd		4		3
Ne	4	4		3
P	-	-	0.60	9
θ	-	-	12	9

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NOTES:

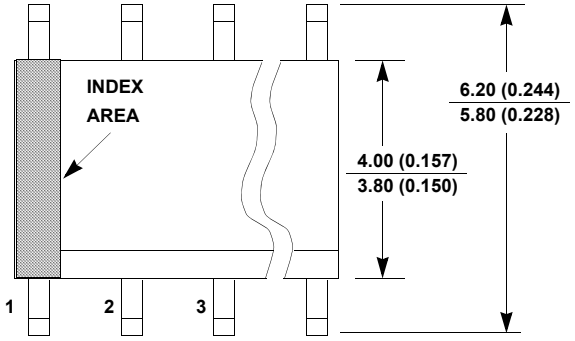
1. Dimensioning and tolerancing conform to ASME Y14.5-1994.
2. N is the number of terminals.
3. Nd and Ne refer to the number of terminals on each D and E.
4. All dimensions are in millimeters. Angles are in degrees.
5. Dimension b applies to the metallized terminal and is measured between 0.15mm and 0.30mm from the terminal tip.
6. The configuration of the pin #1 identifier is optional, but must be located within the zone indicated. The pin #1 identifier may be either a mold or mark feature.
7. Dimensions D2 and E2 are for the exposed pads which provide improved electrical and thermal performance.
8. Nominal dimensions are provided to assist with PCB Land Pattern Design efforts, see Intersil Technical Brief TB389.
9. Features and dimensions A2, A3, D1, E1, P & θ are present when Anvil singulation method is used and not present for saw singulation.
10. Depending on the method of lead termination at the edge of the package, a maximum 0.15mm pull back (L1) maybe present. L minus L1 to be equal to or greater than 0.3mm.

Package Outline Drawing

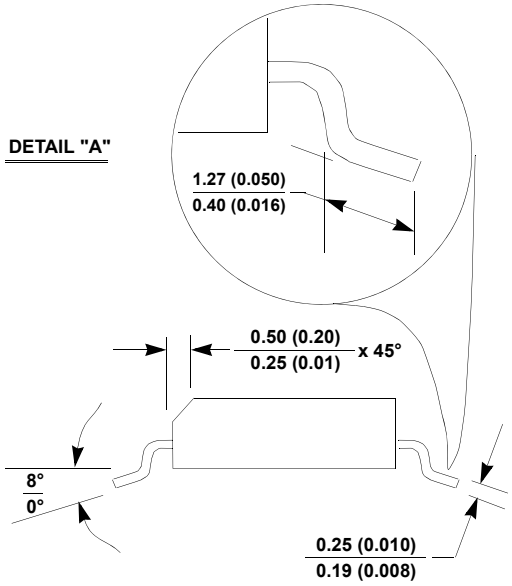
M8.15

8 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

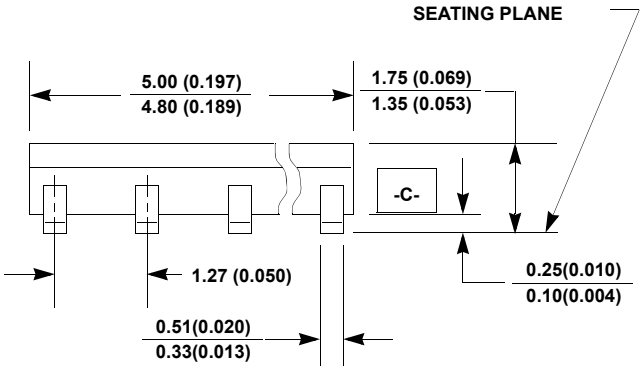
Rev 4, 1/12



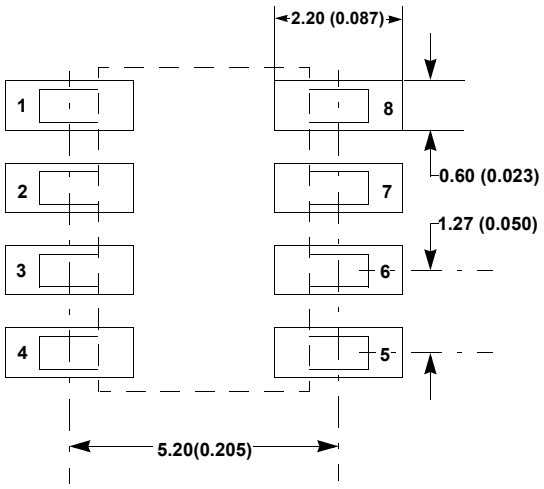
TOP VIEW



SIDE VIEW "B"



SIDE VIEW "A"

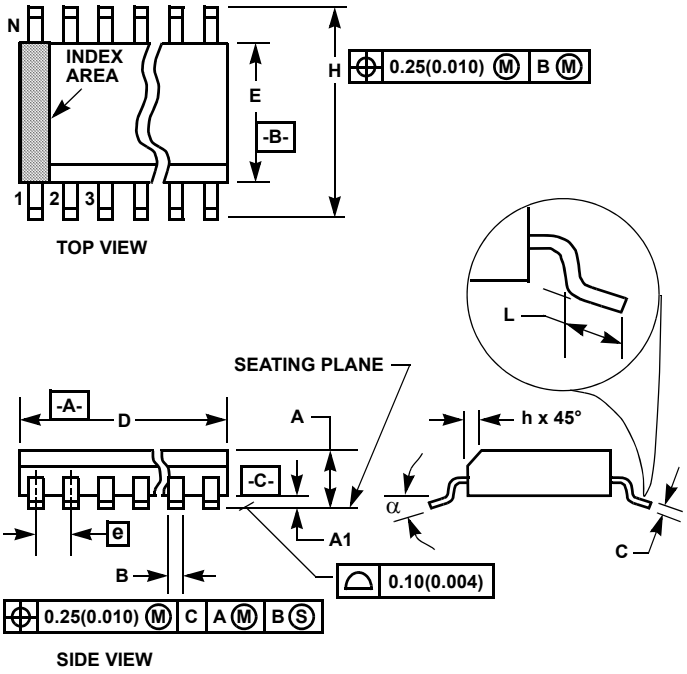


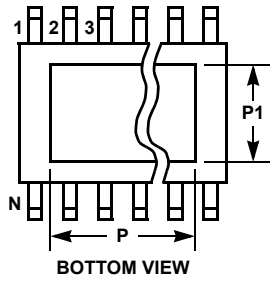
TYPICAL RECOMMENDED LAND PATTERN

NOTES:

1. Dimensioning and tolerancing per ANSI Y14.5M-1994.
2. Package length does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
3. Package width does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
4. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
5. Terminal numbers are shown for reference only.
6. The lead width as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
7. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.
8. This outline conforms to JEDEC publication MS-012-AA ISSUE C.

Small Outline Exposed Pad Plastic Packages (EPSOIC)





M8.15C

8 LEAD NARROW BODY SMALL OUTLINE EXPOSED PAD PLASTIC PACKAGE

SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.056	0.066	1.43	1.68	-
A1	0.001	0.005	0.03	0.13	-
B	0.0138	0.0192	0.35	0.49	9
C	0.0075	0.0098	0.19	0.25	-
D	0.189	0.196	4.80	4.98	3
E	0.150	0.157	3.811	3.99	4
e	0.050 BSC		1.27 BSC		-
H	0.230	0.244	5.84	6.20	-
h	0.010	0.016	0.25	0.41	5
L	0.016	0.035	0.41	0.89	6
N	8		8		7
α	0°	8°	0°	8°	-
P	-	0.126	-	3.200	11
P1	-	0.099	-	2.514	11

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NOTES:

1. Symbols are defined in the “MO Series Symbol List” in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension “D” does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension “E” does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. “L” is the length of terminal for soldering to a substrate.
7. “N” is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width “B”, as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.
11. Dimensions “P” and “P1” are thermal and/or electrical enhanced variations. Values shown are maximum size of exposed pad within lead count and body size.